

## 100324

### Low Power Hex TTL-to-ECL Translator

#### General Description

The 100324 is a hex translator, designed to convert TTL logic levels to 100K ECL logic levels. The inputs are compatible with standard or Schottky TTL. A common Enable (E), when LOW, holds all inverting outputs HIGH and holds all true outputs LOW. The differential outputs allow each circuit to be used as an inverting/non-inverting translator, or as a differential line driver. The output levels are voltage compensated over the full  $-4.2\text{V}$  to  $-5.7\text{V}$  range.

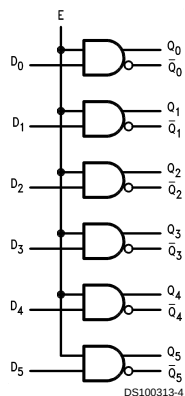
When the circuit is used in the differential mode, the 100324, due to its high common mode rejection, overcomes voltage gradients between the TTL and ECL ground systems. The  $V_{EE}$  and  $V_{TTL}$  power may be applied in either order.

The 100324 is pin and function compatible with the 100124 with similar AC performance, but features power dissipation roughly half of the 100124 to ease system cooling requirements.

#### Features

- Pin/function compatible with 100124
- Meets 100124 AC specifications
- 50% power reduction of the 100124
- Differential outputs
- 2000V ESD protection
- $-4.2\text{V}$  to  $-5.7\text{V}$  operating range
- Standard Microcircuit Drawing (SMD) 5962-9153001

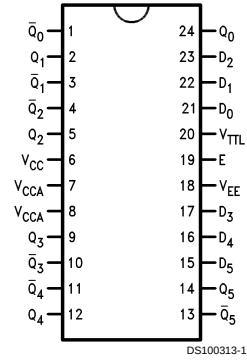
#### Logic Diagram



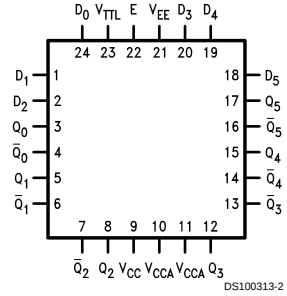
| Pin Names                 | Description                |
|---------------------------|----------------------------|
| $D_0$ – $D_5$             | Data Inputs                |
| E                         | Enable Input               |
| $Q_0$ – $Q_5$             | Data Outputs               |
| $\bar{Q}_0$ – $\bar{Q}_5$ | Complementary Data Outputs |

## Connection Diagrams

24-Pin DIP



24-Pin Quad Cerpak



## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Above which the useful life may be impaired.

|                                        |                 |
|----------------------------------------|-----------------|
| Storage Temperature ( $T_{STG}$ )      | –65°C to +150°C |
| Maximum Junction Temperature ( $T_J$ ) |                 |
| Ceramic                                | +175°C          |
| $V_{EE}$ Pin Potential to Ground Pin   | –7.0V to +0.5V  |
| $V_{TTL}$ Pin Potential to Ground Pin  | –0.5V to +6.0V  |
| Input Voltage (DC)                     | –0.5V to +6.0V  |
| Output Current (DC Output HIGH)        | –50 mA          |

ESD (Note 2)

≥2000V

## Recommended Operating Conditions

Case Temperature ( $T_C$ )

Military

–55°C to +125°C

Supply Voltage ( $V_{EE}$ )

–5.7V to –4.2V

**Note 1:** Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

**Note 2:** ESD testing conforms to MIL-STD-883, Method 3015.

## Military Version

### DC Electrical Characteristics

$V_{EE} = -4.2V$  to  $-5.7V$ ,  $V_{CC} = V_{CCA} = GND$ ,  $T_C = -55^\circ C$  to  $+125^\circ C$ ,  $V_{TTL} = +4.5V$  to  $+5.5V$

| Symbol           | Parameter                             | Min   | Max   | Units | T <sub>C</sub>  | Conditions                                                          |                              | Notes              |
|------------------|---------------------------------------|-------|-------|-------|-----------------|---------------------------------------------------------------------|------------------------------|--------------------|
| V <sub>OH</sub>  | Output HIGH Voltage                   | –1025 | –870  | mV    | 0°C to +125°C   | V <sub>IN</sub> = V <sub>IH</sub> (Max)<br>or V <sub>IL</sub> (Min) | Loading with<br>50Ω to –2.0V | (Notes 3, 4, 5)    |
|                  |                                       | –1085 | –870  | mV    | –55°C           |                                                                     |                              |                    |
| V <sub>OL</sub>  | Output LOW Voltage                    | –1830 | –1620 | mV    | 0°C to +125°C   |                                                                     |                              |                    |
|                  |                                       | –1830 | –1555 | mV    | –55°C           |                                                                     |                              |                    |
| V <sub>OHC</sub> | Output HIGH Voltage                   | –1035 |       | mV    | 0°C to +125°C   | V <sub>IN</sub> = V <sub>IH</sub> (Max)<br>or V <sub>IL</sub> (Min) | Loading with<br>50Ω to –2.0V | (Notes 3, 4, 5)    |
|                  |                                       | –1085 |       | mV    | –55°C           |                                                                     |                              |                    |
| V <sub>OLC</sub> | Output LOW Voltage                    |       | –1610 | mV    | 0°C to +125°C   |                                                                     |                              |                    |
|                  |                                       |       | –1555 | mV    | –55°C           |                                                                     |                              |                    |
| V <sub>IH</sub>  | Input HIGH Voltage                    | 2.0   | 5.0   | V     | –55°C to +125°C | Over V <sub>TTL</sub> , V <sub>EE</sub> , T <sub>C</sub> Range      |                              | (Notes 3, 4, 5, 6) |
| V <sub>IL</sub>  | Input LOW Voltage                     | 0.0   | 0.8   | V     | –55°C to +125°C | Over V <sub>TTL</sub> , V <sub>EE</sub> , T <sub>C</sub> Range      |                              | (Notes 3, 4, 5, 6) |
| I <sub>IH</sub>  | Input HIGH Current                    |       | 20    | μA    | –55°C to +125°C | V <sub>IN</sub> = +2.7V                                             |                              | (Notes 3, 4, 5)    |
|                  | Breakdown Test                        |       | 100   | μA    | –55°C to +125°C | V <sub>IN</sub> = +7.0V                                             |                              |                    |
| I <sub>IL</sub>  | Input LOW Current                     |       |       |       |                 |                                                                     |                              | (Notes 3, 4, 5)    |
|                  | Data                                  | –0.9  |       | mA    | –55°C to +125°C | V <sub>IN</sub> = +0.4V                                             |                              |                    |
|                  | Enable                                | –5.4  |       |       |                 |                                                                     |                              |                    |
| V <sub>FCD</sub> | Input Clamp Diode Voltage             |       | –1.2  | V     | –55°C to +125°C | I <sub>IN</sub> = –18 mA                                            |                              | (Notes 3, 4, 5)    |
| I <sub>EE</sub>  | V <sub>EE</sub> Power Supply Current  | –70   | –22   | mA    | –55°C to +125°C | All Inputs V <sub>IN</sub> = +4.0V                                  |                              | (Notes 3, 4, 5)    |
| I <sub>TTL</sub> | V <sub>TTL</sub> Power Supply Current |       | 38    | mA    | –55°C to +125°C | All Inputs V <sub>IN</sub> = GND                                    |                              | (Notes 3, 4, 5)    |

**Note 3:** F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides “cold start” specs which can be considered a worst case condition at cold temperatures.

**Note 4:** Screen tested 100% on each device at –55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

**Note 5:** Sample tested (Method 5005, Table I) on each manufactured lot at –55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

**Note 6:** Guaranteed by applying specified input condition and testing  $V_{OH}/V_{OL}$ .

## AC Electrical Characteristics

$V_{EE} = -4.2V$  to  $-5.7V$ ,  $V_{CC} = V_{CCA} = GND$ ,  $V_{TTL} = +4.5V$  to  $+5.5V$

| Symbol    | Parameter                 | $T_C = -55^\circ C$ |      | $T_C = +25^\circ C$ |      | $T_C = +125^\circ C$ |      | Units | Conditions   | Notes           |
|-----------|---------------------------|---------------------|------|---------------------|------|----------------------|------|-------|--------------|-----------------|
|           |                           | Min                 | Max  | Min                 | Max  | Min                  | Max  |       |              |                 |
| $t_{PLH}$ | Propagation Delay         | 0.50                | 3.00 | 0.50                | 2.90 | 0.30                 | 3.30 | ns    | Figures 1, 2 | (Notes 7, 8, 9) |
| $t_{PHL}$ | Data and Enable to Output |                     |      |                     |      |                      |      |       |              |                 |
| $t_{TLH}$ | Transition Time           | 0.35                | 1.80 | 0.45                | 1.80 | 0.45                 | 1.80 | ns    |              | (Note 10)       |
| $t_{THL}$ | 20% to 80%, 80% to 20%    |                     |      |                     |      |                      |      |       |              |                 |

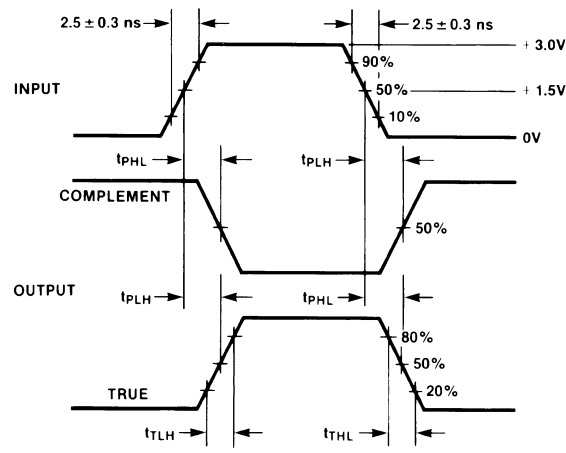
**Note 7:** F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately after power-up. This provides “cold start” specs which can be considered a worst case condition at cold temperatures.

**Note 8:** Screen tested 100% on each device at +25°C temperature only, Subgroup A9.

**Note 9:** Sample tested (Method 5005, Table I) on each manufactured lot at +25°C, Subgroup A9, and at +125°C and –55°C temperatures, Subgroups A10 and A11.

**Note 10:** Not tested at +25°C, +125°C, and –55°C temperature (design characterization data).

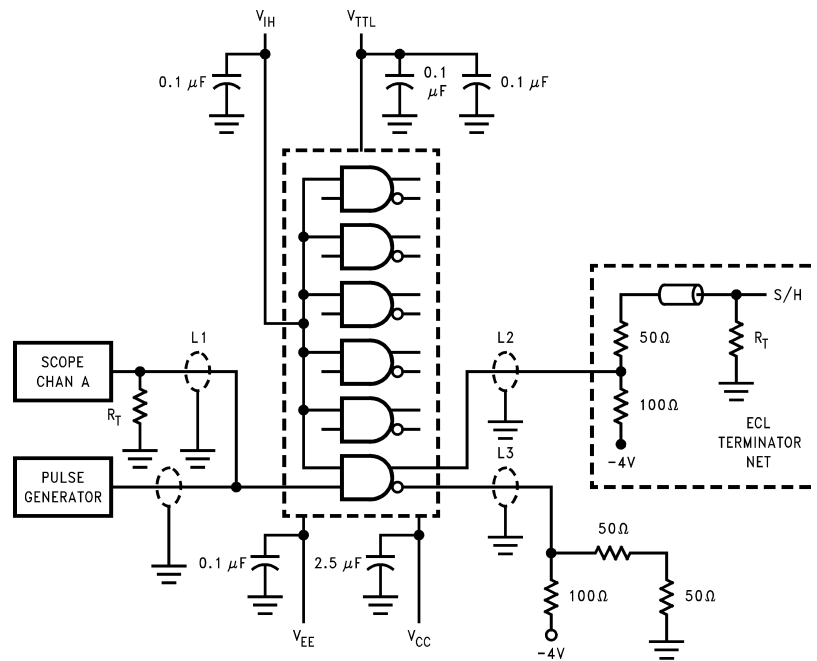
## Switching Waveform



DS100313-6

FIGURE 1. Propagation Delay and Transition Times

## Test Circuit



DS100313-5

### Note:

$V_{CC}$ ,  $V_{CCA}$  = 0V,  $V_{EE}$  = -4.5V,  $V_{TTL}$  = +5.0V,  $V_{IH}$  = +3.0V

L1, L2 and L3 = equal length 50Ω impedance lines

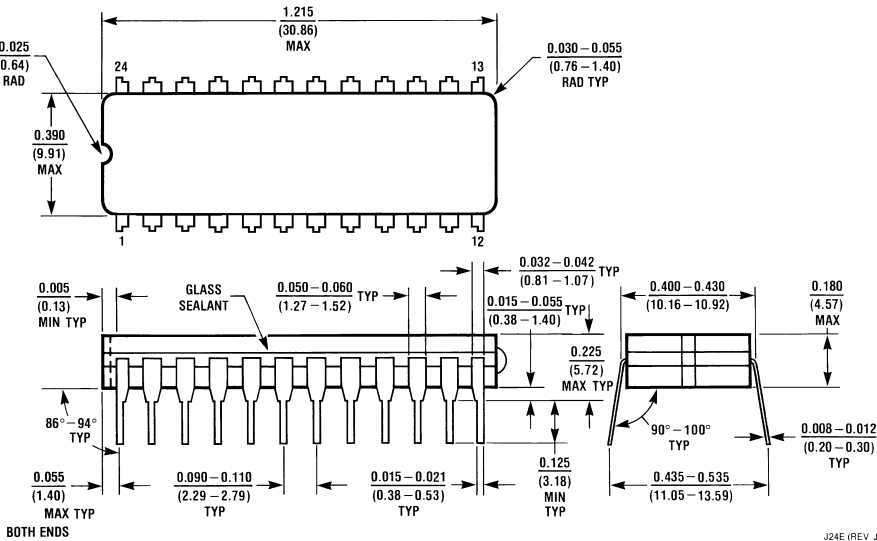
$R_T$  = 50Ω terminator internal to scope

Decoupling 0.1 μF from GND to  $V_{CC}$ ,  $V_{EE}$  and  $V_{TTL}$

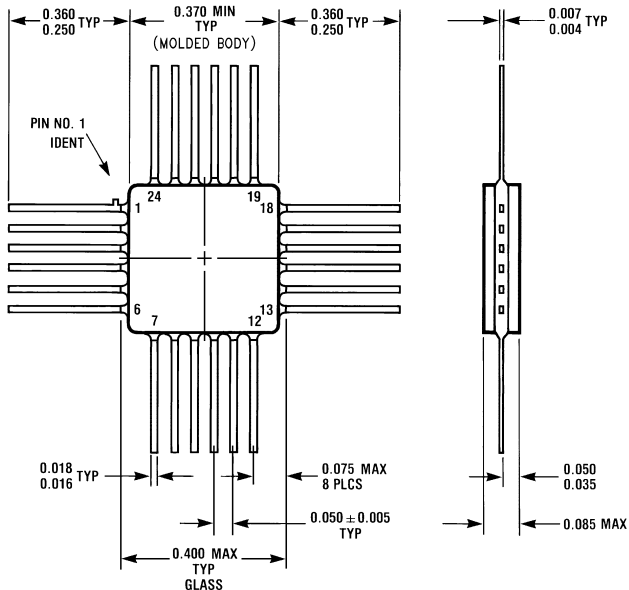
All unused outputs are loaded with 50Ω to -2V or with equivalent ECL terminator network

$C_L$  = Fixture and stray capacitance  $\leq 3$  pF

FIGURE 2. AC Test Circuit

**Physical Dimensions** inches (millimeters) unless otherwise noted

**24-Lead Ceramic Dual-In-Line Package (0.400" Wide) (D)**  
**NS Package Number J24E**



24 Lead Quad Cerpak (F)  
NS Package Number W24B

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